

ON Semiconductor®

FDP085N10A N-Channel PowerTrench[®] MOSFET 100 V, 96 A, 8.5 m Ω

Features

- $R_{DS(on)}$ = 7.35 m Ω (Typ.) @ V_{GS} = 10 V, I_D = 96 A
- Fast Switching Speed
- Low Gate Charge, Q_G = 31 nC (Typ.)
- High Performance Trench Technology for Extremely Low $R_{\text{DS}(\text{on})}$
- High Power and Current Handling Capability
- RoHS Compliant

Description

This N-Channel MOSFET is produced using ON Semiconductor's PowerTrench[®] process that has been tailored to minimize the on-state resistance while maintaining superior switching performance.

Applications

- · Synchronous Rectification for ATX / Server / Telecom PSU
- Battery Protection Circuit
- Motor Drives and Uninterruptible Power Supplies





MOSFET Maximum Ratings T_C = 25°C unless otherwise noted.

Symbol		Parameter	FDP085N10A-F102	Unit	
V _{DSS}	Drain to Source Voltage		100	V	
V _{GSS}	Gate to Source Voltage	Gate to Source Voltage		V	
I _D	Drain Current	- Continuous (T _C = 25 ^o C)	96	A	
		- Continuous (T _C = 100°C)	68		
I _{DM}	Drain Current	- Pulsed (Note 1	384	A	
E _{AS}	Single Pulsed Avalanche Energy (Note 2)		269	mJ	
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	6.0	V/ns	
P _D	Power Dissipation	$(T_{\rm C} = 25^{\rm o}{\rm C})$	188	W	
		- Derate Above 25°C	1.25	W/ºC	
T _J , T _{STG}	Operating and Storage Temperate	-55 to +175	°C		
TL	Maximum Lead Temperature for S	300	°C		

Thermal Characteristics

Symbol	Parameter	FDP085N10A-F102	Unit
$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case, Max.	0.8	°C ///
R_{\thetaJA}	Thermal Resistance, Junction to Ambient, Max.	62.5	0/11

Part Number		Top Mark	Package	Packing Method	Reel Size	Тар	e Width	Qua	ntity
FDP085N10	A-F102	FDP085N10A	TO-220	Tube	N/A	N/A		50 units	
Electrica	l Chara	acteristics T _c =	25ºC unless	otherwise noted.					
Symbol		Parameter		Test Condit	Min.	Тур.	Max.	Unit	
Off Charac	teristics	5							
BV _{DSS}	Drain to Source Breakdown Voltage			I _D = 250 μA, V _{GS} = 0 V,T _C = 25 ^o C		100	-	-	V
ΔBV _{DSS} /ΔTJ	Breakdown Voltage Temperature		$I_D = 250 \ \mu$ A, Referenced to 25° C		-	0.07	-	V/ºC	
I _{DSS}	Zero Ga	te Voltage Drain Curre	$V_{DS} = 80 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = 80 \text{ V}, T_{D} = 150^{\circ}$	-	-	1	μA		
I _{GSS}	Gate to I	Body Leakage Curren	$V_{DS} = 50 \text{ V}, \text{ V}_{C} = 130 \text{ V}$ $V_{GS} = \pm 20 \text{ V}, \text{ V}_{DS} = 0$	V	-	-	±100	nA	
On Charac	toristics				1		1		
	Gate Threshold Voltage			$V = V = 250 \dots A$		2.0	_	4.0	V
$\frac{VGS(th)}{R_{RR}}$	Static Dr	Static Drain to Source On Registance		$V_{GS} = V_{DS}, I_D = 200 \mu$	2.0	7 35	8.5	mO	
Con Con	Forward	Transconductance		$V_{GS} = 10 V, I_D = 96 A$			72	0.0	5
Dynamic C	haracte	ristics					2025	2605	рF
C _{iss}	Output Ca			$V_{DS} = 50 \text{ V}, \text{ V}_{GS} = 0 \text{ V},$		-	2025	2095	рг
C	Duipui C			f = 1 MHz		-	400	020	pr
Crss	Enorgy	/erse Transfer Capacitance				-	20	-	рг
O _{oss(er)}	Total Ga	nergy Releted Output Capacitance		$v_{\rm DS} = 50 v, v_{\rm GS} = 0 v$		-	31	- 40	pi nC
$Q_{g(tot)}$	Gate to 9	Source Gate Charge					97	40	nC
	Gate Ch	Gate to Source Gate Charge		$V_{GS} = 10^{\circ}$, $V_{DS} = 50^{\circ}$,			5.0		nC
Qgs2	Gate to I	Drain "Miller" Charge	icau	(Note 4)		_	7.5	_	nC
<u>«ga</u> ESR	Equivale			f = 1 MHz	-	0.97	_	0	
Switching	Charact	eristics	(0,0)				0.07		
t _{d(on)}	Turn-On	Delay Time		$V_{DD} = 50 \text{ V}, \text{ I}_{D} = 96 \text{ A},$ $V_{GS} = 10 \text{ V}, \text{ R}_{G} = 4.7 \Omega$		-	18	46	ns
t _r	Turn-On	Rise Time				-	22	54	ns
t _{d(off)}	Turn-Off	Delay Time				-	29	68	ns
t _f	Turn-Off	Fall Time		_	(Note 4)	-	8	26	ns
Drain-Sour	ce Diod	e Characteristic	s						
I _S	Maximum Continuous Drain to Source Diode Forward Current				-	-	96	Α	
I _{SM}	Maximun	n Pulsed Drain to Sou	rce Diode Fo	rward Current	-	-	384	Α	
Ven	Drain to	Source Diode Forward	urce Diode Forward Voltage		V _{GS} = 0 V, I _{SD} = 96 A		-	1.3	V
30	Reverse	Recovery Time		$V_{DD} = 50 V, V_{GS} = 0 V, I_{SD} = 96 A,$ $dI_F/dt = 100 A/\mu s$		-	59	-	ns
t _{rr}		-					80	1	nC



Figure 2. Transfer Characteristics



Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature



Figure 6. Gate Charge Characteristics





Typical Performance Characteristics (Continued)







Figure 11. Eoss vs. Drain to Source Voltage









DUT + v_{DS} 0 I_{SD} L Driver R_G Same Type as DUT Ļ v₀₀ ∏∏ V_{GS} • dv/dt controlled by R_{G} • I_{SD} controlled by pulse period Î Gate Pulse Width V_{GS} D = Gate Pulse Period 10V (Driver) \mathbf{I}_{FM} , Body Diode Forward Current I _{SD} di/dt (DUT) I_{RM} Body Diode Reverse Current V_{DS} (DUT) Body Diode Recovery dv/dt $V_{\rm SD}$ V_{PD} Body Diode Forward Voltage Drop Figure 17. Peak Diode Recovery dv/dt Test Circuit & Waveforms



Package drawings are provided as a service to customers considering ON Semiconductor components. Drawings may change in any manner without notice. Please note the revision and/or date on the drawing and contact a ON Semiconductor representative to verify or obtain the most recent revision. Package specifications do not expand the terms of ON Semiconductor's worldwide terms and conditions, specifically the warranty therein, which covers ON Semiconductor products.

ON Semiconductor and are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at <u>www.onsemi.com/site/pdf/Patent-Marking.pdf</u>. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor haves against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death as

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor 19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com N. American Technical Support: 800–282–9855 Toll Free USA/Canada Europe, Middle East and Africa Technical Support: Phone: 421 33 790 2910

Japan Customer Focus Center Phone: 81–3–5817–1050 ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative